Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/686,226	GRAF ET AL.	
Examiner	**Art Unit**	
Quynh H. Nguyen	2614	

SEARCHED			
Class	Subclass	Date	Examiner
379	219 220.01 221.07 221.08 224 258	1/11/07	QN
370	385 522 524 373 377 384 385	1/11/07	QN

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Searched: East, USPGPub, USPAT	1/11/07	QN
Inventor searched through PALM database	1/11/07	QN